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Sheet 2 of 10 US Dept. of Commerce ATTY DOCKET NO. **APPLICATION** Form PTO-1449 (REV. 1/06) PATENT & TRADEMARK OFFICE NO. 128253 10/581,307 INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary) **APPLICANTS** Hiroyuki NAGASAKA et al. FILING DATE September 26, 2006 U.S. PATENT DOCUMENTS Cite Examiner Date Name Initials No. Document Number VOGEL et al. 2004/0257544 A1 12/23/2004 20 /am/ 21 2004/0263808 A1 12/30/2004 **SEWELL** YEO et al. 02/17/2005 22 2005/0036183 A1 02/17/2005 YEO et al. 23 2005/0036184 A1 2005/0037269 A1 02/17/2005 LEVINSON 24 25 2005/0036213 A1 02/17/2005 MANN et al. ENDO et al. 11/11/2004 2004/0224265 A1 26 ENDO et al. 27 2004/0224525 A1 11/11/2004 28 2005/0046934 A1 03/03/2005 HO et al. PAWLOSKI et al. 29 2005/0048223 A1 03/03/2005 ENDO et al. 30 2004/0253547 A1 12/16/2004 31 2004/0253548 A1 12/16/2004 ENDO et al. PIERRAT et al. 32 2005/0068639 A1 03/31/2005 04/07/2005 **CARROLL** 2005/0073670 A1 33 2005/0084794 A1 04/21/2005 MEAGLEY et al. 34 35 2005/0094116 A1 05/05/2005 FLAGELLO et al. 05/12/2005 LIN et al. 36 2005/0100745 A1 LOF et al. 37 2004/0136494 A1 07/15/2004 38 2004/0160582 A1 08/19/2004 LOF et al. /AM/ FOREIGN PATENT DOCUMENTS With With Examiner Cite English English No. Document Number Date Country Abstract Translation OTHER DOCUMENTS

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